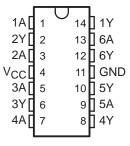
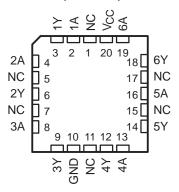


XD54LS04...W PACKAGE (TOP VIEW)



XL74LS04 XD74LS04 XD54LS04

XD54LS04 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

ORDERING INFORMATION

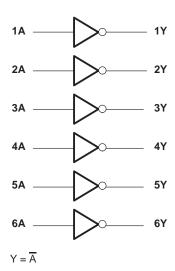
TA	PAC	CKAGET	ORDERABLE PART NUMBER	TOP-SIDE MARKING
		Tube		
	PDIP – N	Tube	XD74LS04	XD74LS04
		Tube		
		Tube		7404
	SOIC - D	Tape and reel		7404
		Tube	XL74LS04	LS04
0°C to 70°C		Tape and reel	XL14L304	L304
		Tube		S04
		Tape and reel		504
		Tape and reel		SN7404
	SOP - NS	Tape and reel	XL74LS04NS	74LS04
		Tape and reel	XL74L304N3	74\$04
	SSOP - DB	Tape and reel		LS04
		Tube		
		Tube		
	CDIP – J	Tube		
	CDIP = 3	Tube		
		Tube		
–55°C to 125°C		Tube		
		Tube		
	CFP – W	Tube		
		Tube		
	LCCC - FK	Tube		
	LUCU - FK	Tube		

1

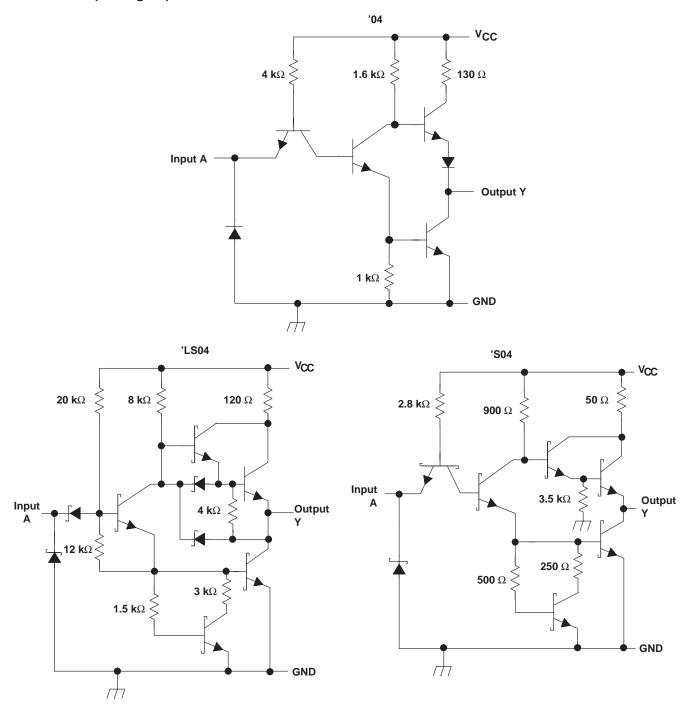
FUNCTION TABLE (each inverter)

INPUT A	OUTPUT Y
Н	L
L	Н

logic diagram (positive logic)



schematics (each gate)



Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)		7 V
Input voltage, V _I : '04, 'S04		5.5 V
'LS04		
Package thermal impedance, θ _{JA} (see Note 2): D package	86°C/W
, , , , , , , , , , , , , , , , , , , ,	DB package	96°C/W
	N package	80°C/W
	NS package	76°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. This are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 3)

		XΙ	054LS04		XL	74LS04		UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
ІОН	High-level output current			-0.4			-0.4	mA
loL	Low-level output current			16			16	mA
TA	Operating free-air temperature	-55		125	0		70	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER		TEGT 0011DITIO			XD54LS	04		XL74LS)4	
PARAMETER		TEST CONDITIO	JNS+	MIN	TYP§	MAX	MIN	TYP§	MAX	UNIT
VIK	$V_{CC} = MIN,$	$I_{I} = -12 \text{ mA}$				-1.5			-1.5	V
Voн	$V_{CC} = MIN,$	$V_{IL} = 0.8 V$,	$I_{OH} = -0.4 \text{ mA}$	2.4	3.4		2.4	3.4		V
VOL	$V_{CC} = MIN,$	V _{IH} = 2 V,	$I_{OL} = 16 \text{ mA}$		0.2	0.4		0.2	0.4	V
lį	$V_{CC} = MAX$,	V _I = 5.5 V				1			1	mA
lΗ	$V_{CC} = MAX$,	V _I = 2.4 V				40			40	μΑ
I _Ι Γ	$V_{CC} = MAX$,	V _I = 0.4 V				-1.6			-1.6	mA
los¶	VCC = MAX			-20		-55	-18		-55	mA
ІССН	$V_{CC} = MAX$,	V _I = 0 V	·		6	12		6	12	mA
ICCL	$V_{CC} = MAX$,	V _I = 4.5 V			18	33		18	33	mA

[‡] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTES: 1. Voltage values are with respect to network ground terminal.

^{2.} The package thermal impedance is calculated in accordance with JESD 51-7.

[§] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

 $[\]P$ Not more than one output should be shorted at a time.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see Figure 1)

PARAMETER	PARAMETER FROM TO TEST CONDITIONS			(D54LS((L74LS(_	UNIT		
	(IIVFOT)	(001701)		MIN	TYP	MAX		
t _{PLH}	۸	V	P 400 O	C: _ 15 pE		12	22	no
t _{PHL}	A	Ť	$R_L = 400 \Omega$,	$C_L = 15 pF$		8	15	ns

recommended operating conditions (see Note 3)

		×	D54LS04	4	Х	L74LS04	4	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-0.4			-0.4	mA
lOL	Low-level output current			4			8	mA
TA	Operating free-air temperature	-55		125	0		70	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEGT 0011DIT	auat .	Х	D54LS0	4	Х	L74LS04	ı	
PARAMETER		TEST CONDITION	ONSI	MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	UNIT
VIK	$V_{CC} = MIN,$	$I_{I} = -18 \text{ mA}$				-1.5			-1.5	V
Voн	$V_{CC} = MIN,$	$V_{IL} = MAX$,	$I_{OH} = -0.4 \text{ mA}$	2.5	3.4		2.7	3.4		V
V	\/ MINI	V _{IH} = 2 V	$I_{OL} = 4 \text{ mA}$		0.25	0.4			0.4	V
VOL	$V_{CC} = MIN,$	VIH = 2 V	I _{OL} = 8 mA					0.25	0.5	٧
ΙĮ	$V_{CC} = MAX$,	V _I = 7 V				0.1			0.1	mA
lіН	$V_{CC} = MAX$,	V _I = 2.7 V				20			20	μΑ
Ι _{ΙL}	$V_{CC} = MAX$,	V _I = 0.4 V				-0.4			-0.4	mA
los§	VCC = MAX			-20		-100	-20		-100	mA
ICCH	$V_{CC} = MAX$,	V _I = 0 V			1.2	2.4		1.2	2.4	mA
ICCL	V _{CC} = MAX,	V _I = 4.5 V			3.6	6.6		3.6	6.6	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST C	XI XI	UNIT			
	(IIVFOT)	(001F01)		MIN	TYP	MAX		
t _{PLH}	^	V	P 2 kO	C: - 15 pE		9	15	no
^t PHL	A	Ť	$R_L = 2 k\Omega$,	$C_L = 15 pF$		10	15	ns

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[§] Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

recommended operating conditions (see Note 3)

		XD	54LS04		,	XL74LS0)4	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
loh	High-level output current			-1			-1	mA
loL	Low-level output current			20			20	mA
TA	Operating free-air temperature	-55		125	0		70	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

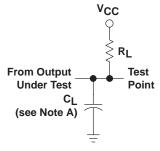
DADAMETER		TEGT CONDITIO	-vot)	CD54LS0)4)	KL74LS0	4	
PARAMETER		TEST CONDITION	ONSI	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	$V_{CC} = MIN,$	$I_{I} = -18 \text{ mA}$				-1.2			-1.2	V
Voн	$V_{CC} = MIN,$	$V_{IL} = 0.8 V$,	$I_{OH} = -1 \text{ mA}$	2.5	3.4		2.7	3.4		V
VOL	$V_{CC} = MIN,$	V _{IH} = 2 V,	$I_{OL} = 20 \text{ mA}$			0.5			0.5	V
lį	$V_{CC} = MAX$,	V _I = 5.5 V				1			1	mA
liΗ	$V_{CC} = MAX$,	V _I = 2.7 V				50			50	μΑ
Iμ	$V_{CC} = MAX$,	V _I = 0.5 V				-2			-2	mA
I _{OS} §	V _{CC} = MAX			-40		-100	-40		-100	mA
Іссн	$V_{CC} = MAX$,	V _I = 0 V			15	24		15	24	mA
ICCL	V _{CC} = MAX,	V _I = 4.5 V			30	54		30	54	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see Figure 1)

PARAMETER	RAMETER FROM TO TEST CONDITIONS		XD54LS04 XL74LS04					
	(INFOT)	(001-01)			MIN	TYP	MAX	
^t PLH	^	V	B 200 O	C _L = 15 pF		3	4.5	no
t _{PHL}	A	T	$R_L = 280 \Omega$,	ο <u>L</u> = 15 μι		3	5	ns
^t PLH	۸		$R_1 = 280 \Omega$	C ₁ = 50 pF		4.5		ne
t _{PHL}	А	ľ	N_ = 200 22,	GL = 30 pr		5		ns

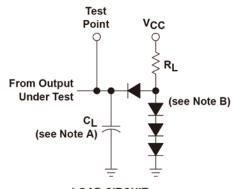
PARAMETER MEASUREMENT INFORMATION SERIES 54/74 AND 54S/74S DEVICES



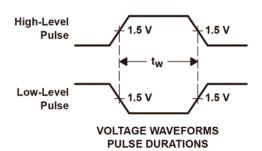
LOAD CIRCUIT FOR OPEN-COLLECTOR OUTPUTS

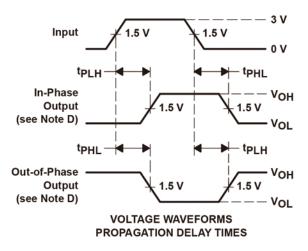
[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

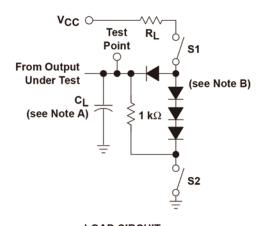
[§] Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

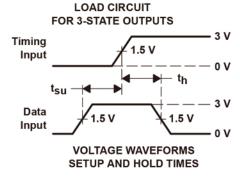


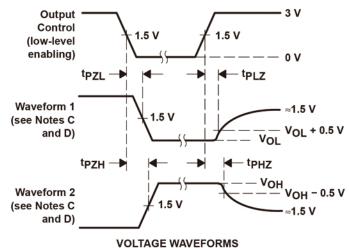
LOAD CIRCUIT
FOR 2-STATE TOTEM-POLE OUTPUTS











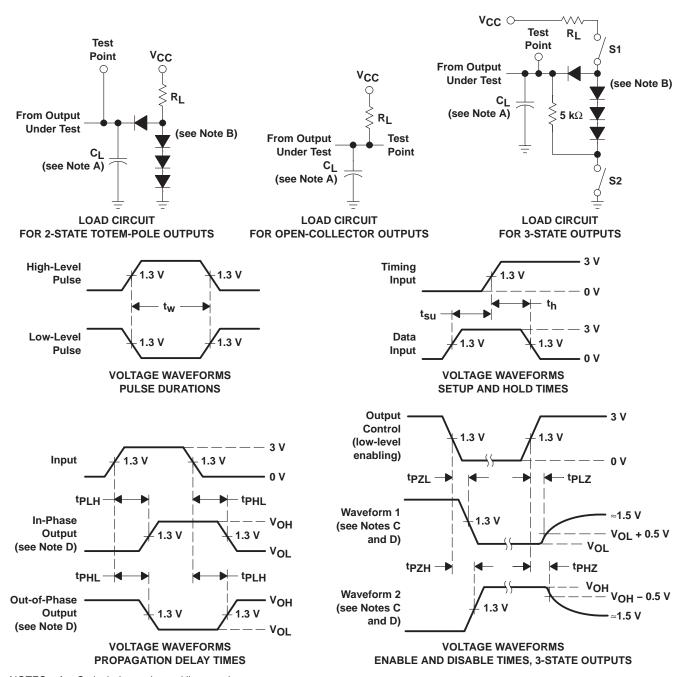
ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS

NOTES: A. C_L includes probe and jig capacitance.

- B. All diodes are 1N3064 or equivalent.
- C. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- D. S1 and S2 are closed for tpLH, tpHL, tpHZ, and tpLZ; S1 is open and S2 is closed for tpZH; S1 is closed and S2 is open for tpZL.
- E. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O \approx$ 50 Ω ; t_r and $t_f \leq$ 7 ns for Series 54/74 devices and t_r and $t_f \leq$ 2.5 ns for Series 54S/74S devices.
- F. The outputs are measured one at a time, with one input transition per measurement.

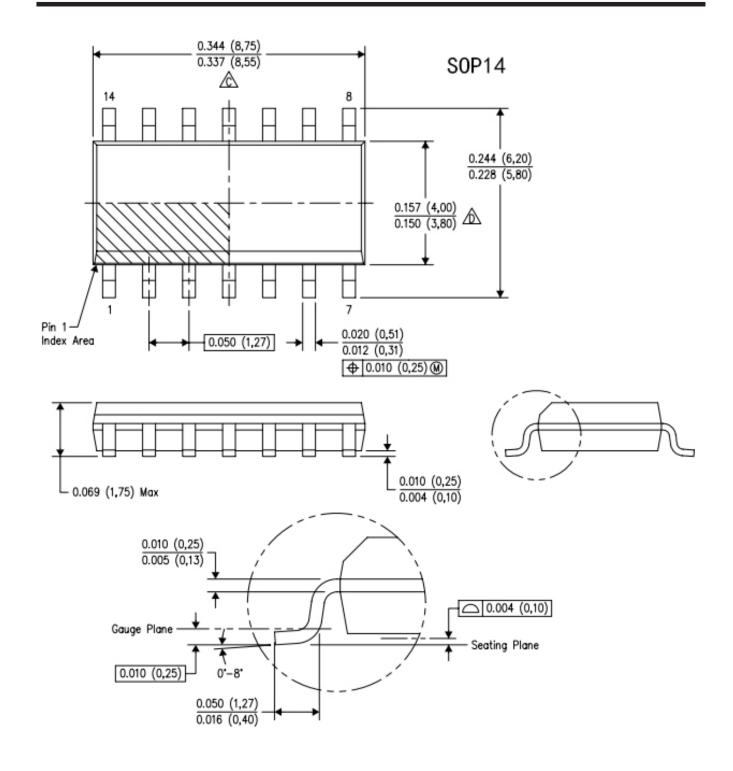
Figure 1. Load Circuits and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION SERIES 54LS/74LS DEVICES



- NOTES: A. C_L includes probe and jig capacitance.
 - B. All diodes are 1N3064 or equivalent.
 - C. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - D. S1 and S2 are closed for tpLH, tpHL, tpHZ, and tpLZ; S1 is open and S2 is closed for tpZH; S1 is closed and S2 is open for tpZL.
 - E. Phase relationships between inputs and outputs have been chosen arbitrarily for these examples.
 - F. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O \approx 50 \ \Omega$, $t_f \leq$ 1.5 ns, $t_f \leq$ 2.6 ns.
 - G. The outputs are measured one at a time, with one input transition per measurement.

Figure 2. Load Circuits and Voltage Waveforms



DIP14

